



N-channel 800 V, 0.95 Ω typ., 5 A MDmesh™ K5 Power MOSFET in a DPAK package

Datasheet - production data

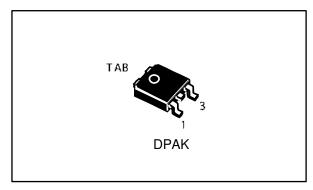
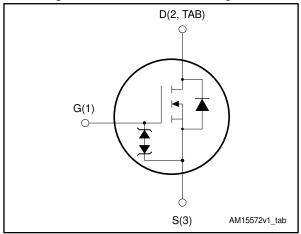


Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	DS R _{DS(on)} max.	
STD7LN80K5	800 V	1.15 Ω	5 A

- Industry's lowest R_{DS(on)} x area
- Industry's best figure of merit (FoM)
- Ultra-low gate charge
- 100% avalanche tested
- Zener-protected

Applications

Switching applications

Description

This very high voltage N-channel Power MOSFET is designed using MDmesh™ K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

Table 1: Device summary

Order code	Marking	Package	Packing	
STD7LN80K5	7LN80K5	DPAK	Tape and reel	

Contents STD7LN80K5

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STD7LN80K5 Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{GS}	Gate-source voltage	± 30	V
I _D ⁽¹⁾	Drain current (continuous) at T _C = 25 °C	5	Α
I _D ⁽¹⁾	Drain current (continuous) at T _C = 100 °C	3.4	Α
I _D ⁽²⁾	I _D ⁽²⁾ Drain current (pulsed)		Α
P _{TOT}	Total dissipation at T _C = 25 °C	85	W
dv/dt ⁽³⁾	Peak diode recovery voltage slope	4.5	V/ns
dv/dt ⁽⁴⁾	dv/dt ⁽⁴⁾ MOSFET dv/dt ruggedness		V/ns
T _{stg}	Storage temperature	EE to 150	°C
Tj	Operating junction temperature	- 55 to 150	C

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit	
R _{thj-case}	Thermal resistance junction-case	1.47	°C/W	
R _{thj-pcb} ⁽¹⁾	Thermal resistance junction-pcb	50	°C/W	

Notes:

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetetive or not repetetive (pulse width limited by T _{jmax})		Α
Eas	(Single pulse avalanche energy (starting T_j = 25 °C, I_D = I_{AR} ; V_{DD} = 50 V)	200	mJ

 $^{^{(1)}}$ Limited by maximum junction temperature.

⁽²⁾Pulse width limited by safe operating area.

 $^{^{(3)}}$ I_{SD} \leq 5 A, di/dt \leq 100 A/µs; V_{DS peak} < V_{(BR)DSS}, V_{DD}=640 V

 $^{^{(4)}}V_{DS} \le 640 \text{ V}$

 $^{^{(1)}\!}When$ mounted on FR-4 board of 1 inch², 2 oz Cu

Electrical characteristics STD7LN80K5

2 Electrical characteristics

T_C = 25 °C unless otherwise specified

Table 5: On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	800			٧
	Zoro goto voltago Droin	$V_{GS} = 0 \text{ V}, V_{DS} = 800 \text{ V}$			1	μΑ
I _{DSS}	I _{DSS} Zero gate voltage Drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 800 \text{ V},$ $T_{C} = 125 \text{ °C}$			50	μΑ
I _{GSS}	Gate-body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$			±10	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 100 \mu A$	3	4	5	٧
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D = 2.5 A		0.95	1.15	Ω

Table 6: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	270	-	pF
Coss	Output capacitance	$V_{DS} = 100 \text{ V}, f = 1 \text{ MHz},$	-	22	1	pF
C _{rss}	Reverse transfer capacitance	$V_{GS} = 0 V$	-	0.5	-	pF
C _{o(er)} ⁽¹⁾	Equivalent capacitance energy related		-	17	-	nC
C _{o(tr)} ⁽²⁾	Equivalent capacitance time related	$V_{DS} = 0$ to 640 V, $V_{GS} = 0$ V	-	48	-	nC
R_g	Intrinsic gate resistance	f = 1 MHz, I _D =0 A	-	7.5	-	Ω
Q_g	Total gate charge	$V_{DD} = 640 \text{ V}, I_D = 5 \text{ A},$	-	12	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 10 V (see Figure 15: "Test circuit for gate charge	-	2.6	1	nC
Q_{gd}	Gate-drain charge	behavior")	-	8.6	-	nC

Notes:

Table 7: Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	$V_{DD} = 400 \text{ V}, I_D = 2.5 \text{ A}, R_G = 4.7 \Omega,$	ı	9.3	1	ns
t _r	Rise time	V _{GS} = 10 V (see Figure 14: "Test circuit for resistive load switching times" and Figure 19: "Switching time	1	6.7	-	ns
t _{d(off)}	Turn-off-delay time		-	23.6	-	ns
t _f	Fall time	waveform")	ı	17.4	-	ns



 $^{^{(1)}}$ Energy related is defined as a constant equivalent capacitance giving the same stored energy as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

 $^{^{(2)}}$ Time related is defined as a constant equivalent capacitance giving the same stored energy as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Table 8: Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		5	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		20	Α
V _{SD} ⁽²⁾	Forward on voltage	$I_{SD}=5 A$, $V_{GS}=0 V$,	-		1.6	V
t _{rr}	Reverse recovery time	I _{SD} = 5 A, di/dt = 100 A/μs,	-	276		ns
Q _{rr}	Reverse recovery charge	V _{DD} = 60 V (see Figure 16: "Test circuit for inductive load	-	2.13		μC
I _{RRM}	Reverse recovery current	switching and diode recovery times")	-	15.4		Α
t _{rr}	Reverse recovery time	I _{SD} = 5 A, di/dt = 100 A/μs,	-	402		ns
Q _{rr}	Reverse recovery charge	V _{DD} = 60 V, T _j = 150 °C (see Figure 16: "Test circuit for inductive load switching and diode recovery times")	-	2.79		μС
I _{RRM}	Reverse recovery current		-	13.9		Α

Notes:

Table 9: Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
$V_{(BR)GSO}$	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{ mA}, I_{D} = 0 \text{ A}$	30	-		V	

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.

⁽¹⁾Pulse width is limited by safe operating area

 $^{^{(2)}}$ Pulsed: pulse duration = 300 μ s, duty cycle 1.5%

2.2 Electrical characteristics (curves)

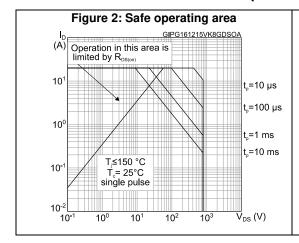


Figure 3: Thermal impedance $K = \frac{GC20460}{10^{-1}}$ $\delta = 0.5$ $\delta = 0.2$ $\delta = 0.05$ $\delta = 0.02$ $\delta = 0.01$ $\delta = 0.01$ Single pulse 10^{-3} 10^{-5} 10^{-4} 10^{-3} 10^{-1} 10^{-1} 10^{-1} 10^{-1} 10^{-1} 10^{-1} 10^{-1} 10^{-1} 10^{-1} 10^{-1} 10^{-1} 10^{-1} 10^{-1} 10^{-1}

Figure 4: Output characteristics

GIPG1512201511290CH

V_{GS} = 11 V

V_{GS} = 9 V

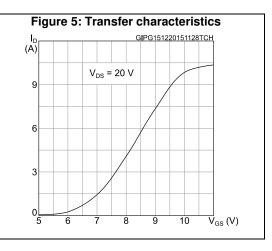
V_{GS} = 8 V

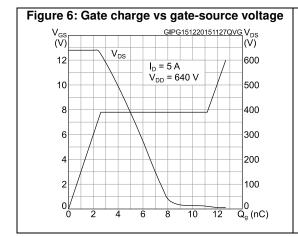
V_{GS} = 6 V

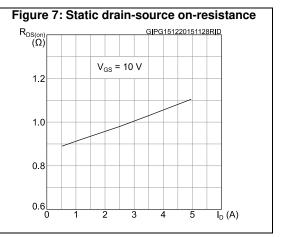
V_{GS} = 6 V

V_{GS} = 6 V

V_S = 6 V







STD7LN80K5 Electrical characteristics

Figure 8: Capacitance variations

C
(pF)

10³

10²

10¹

f = 1 MHz

Coss
C_{RSS}

10⁻¹

10⁻¹

10⁻¹

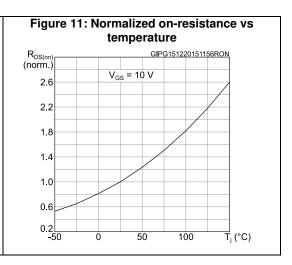
10⁻¹

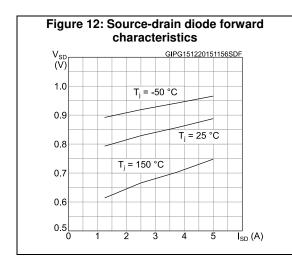
10⁰

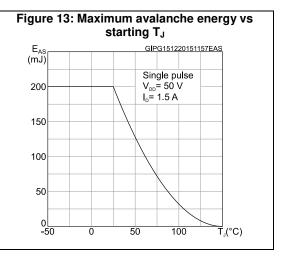
10¹

10²

V_{DS} (V)







Test circuits STD7LN80K5

Test circuits 3

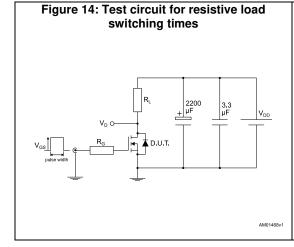


Figure 15: Test circuit for gate charge behavior 1 kΩ ⊥ 100 nF I_G= CONST 2.7 kΩ 47 kΩ

Figure 16: Test circuit for inductive load switching and diode recovery times

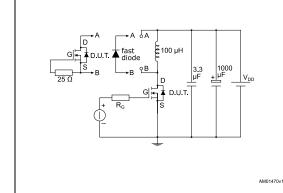


Figure 17: Unclamped inductive load test circuit

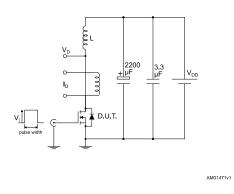


Figure 18: Unclamped inductive waveform

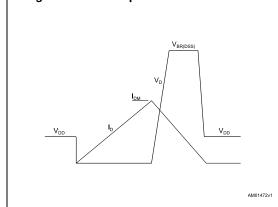
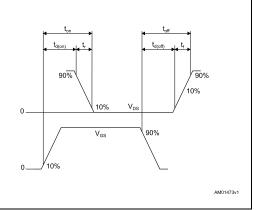


Figure 19: Switching time waveform



STD7LN80K5 Package information

4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

4.1 DPAK (TO-252) type A2 package information

Figure 20: DPAK (TO-252) type A2 package outline

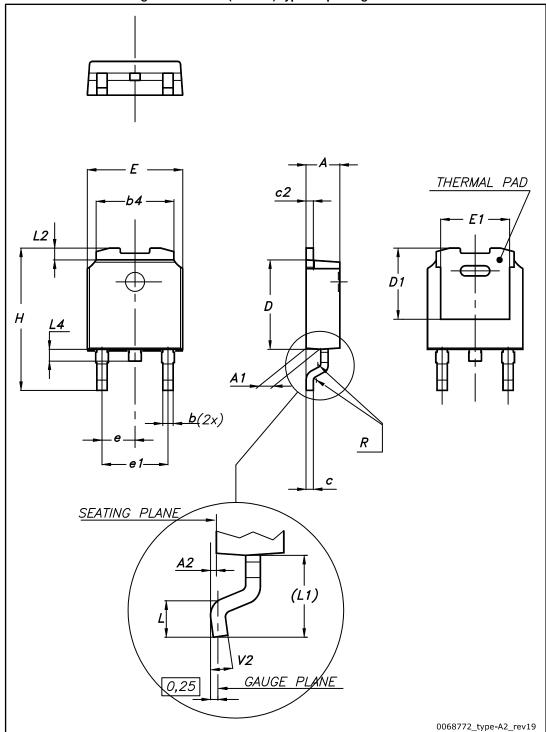


Table 10: DPAK (TO-252) type A2 mechanical data

Dim	,	mm	
Dim.	Min.	Тур.	Max.
А	2.20		2.40
A1	0.90		1.10
A2	0.03		0.23
b	0.64		0.90
b4	5.20		5.40
С	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
D1	4.95	5.10	5.25
Е	6.40		6.60
E1	5.10	5.20	5.30
е	2.16	2.28	2.40
e1	4.40		4.60
Н	9.35		10.10
L	1.00		1.50
L1	2.60	2.80	3.00
L2	0.65	0.80	0.95
L4	0.60		1.00
R		0.20	
V2	0°		8°

Package information

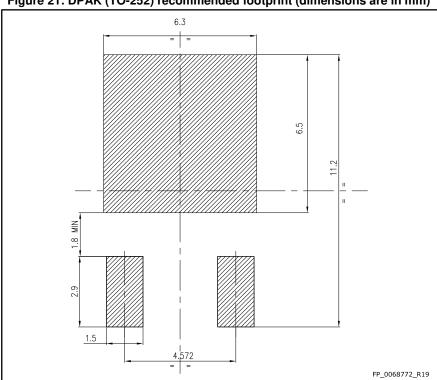
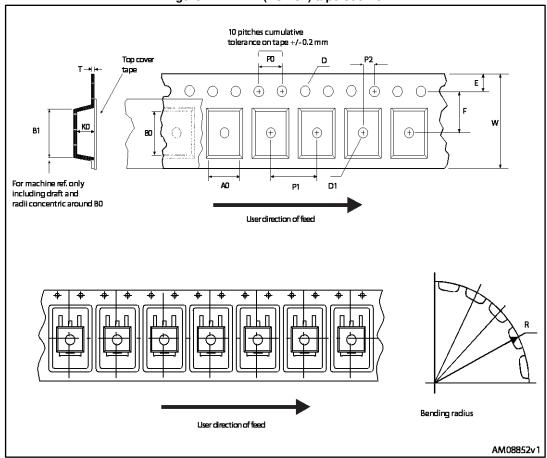


Figure 21: DPAK (TO-252) recommended footprint (dimensions are in mm)

STD7LN80K5 Package information

4.2 DPAK (TO-252) packing information

Figure 22: DPAK (TO-252) tape outline



40mm min. access hole at slot location С Ν G measured Tape slot at hub in core for Full radius tape start 2.5mm min.width

Figure 23: DPAK (TO-252) reel outline

Table 11: DPAK (TO-252) tape and reel mechanical data

AM06038v1

	Таре		Reel		
Dim.	mm		Dim.	mm	
	Min.	Max.	Dilli.	Min.	Max.
A0	6.8	7	Α		330
В0	10.4	10.6	В	1.5	
B1		12.1	С	12.8	13.2
D	1.5	1.6	D	20.2	
D1	1.5		G	16.4	18.4
E	1.65	1.85	N	50	
F	7.4	7.6	Т		22.4
K0	2.55	2.75			
P0	3.9	4.1	Base qty. 250		2500
P1	7.9	8.1	Bulk qty. 2500		2500
P2	1.9	2.1			
R	40				
Т	0.25	0.35			
W	15.7	16.3			

STD7LN80K5 Revision history

5 Revision history

Table 12: Document revision history

Date	Revision	Changes
16-Dec-2015	1	First release.

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